

## -10A, -30V P-Channel Power MOSFET

### GENERAL DESCRIPTION

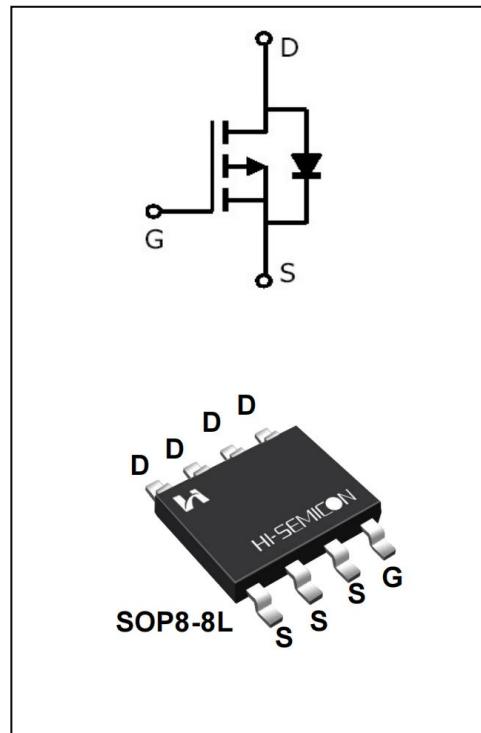
The Power MOSFET has extremely low on resistance, making it especially suitable for applications which require superior power density and outstanding efficiency.

### Features

- ◆  $V_{DS}=-30V$ ,  $I_D=-10A$
- ◆  $R_{DS(ON)}$   
TYP:  $12.8m\Omega$  @  $V_{GS} = -10V$   
TYP:  $21.3m\Omega$  @  $V_{GS} = -4.5V$

### Applications

- ◆ Power factor correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power



### ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFS4435	SOP8-8L	SFS4435	Pb Free	Reel

ABSOLUTE MAXIMUM RATINGS ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Characteristics	Symbol	Ratings	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Drain Current	$I_D$	-10	A
$T_C = 75^\circ\text{C}$		-8.5	
Drain Current Pulsed (Note 1)	$I_{DM}$	-40	
Power Dissipation( $T_C=25^\circ\text{C}$ ) -Derate above $25^\circ\text{C}$	$P_D$	3.1	W
Single Pulsed Avalanche Energy (Note 2)	$E_{AS}$	112	mJ
Operation Junction Temperature Range	$T_J$	-55~+150	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-55~+150	
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	$TL$	300	

## ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	$B_{VDSS}$	$V_{GS}= 0\text{V}, I_D= -250\mu\text{A}$	-30	--	--	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}= -30\text{V}, V_{GS}= 0\text{V}$	--	--	1.0	$\mu\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}= 20\text{V}, V_{DS}= 0\text{V}$	--	--	100	nA
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}= -20\text{V}, V_{DS}= 0\text{V}$	--	--	-100	
On Characteristics						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}= V_{DS}, I_D= -250\mu\text{A}$	-1.0	-1.8	-2.5	V
Static Drain- Source On State Resistance	$R_{DS(on)}$	$V_{GS}= -10\text{V}, I_D= -8\text{A}$	--	12.8	18	$\text{m}\Omega$
		$V_{GS}= -4.5\text{V}, I_D= -6\text{A}$	--	21.3	28	
Dynamic Characteristics						
Input Capacitance	$C_{iss}$	$V_{DS}= -20\text{V}$ $V_{GS}= 0\text{V}$ $f=1.0\text{MHZ}$	--	1436	--	pF
Output Capacitance	$C_{oss}$		--	172	--	
Reverse Transfer Capacitance	$C_{rss}$		--	138	--	
Switching Characteristics						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}= -15\text{V}, V_{GS}= -10\text{V}$ $R_G= 6\Omega, I_D= -8.0\text{A}$ (Note 3.4)	--	12.3	--	nS
Turn-on Rise Time	$t_r$		--	13.7	--	
Turn-off Delay Time	$t_{d(off)}$		--	68.4	--	
Turn-off Fall Time	$t_f$		--	30.5	--	
Total Gate Charge	$Q_g$	$V_{DS}=-15\text{V}, I_D=-8.0\text{A}$ $V_{GS}=-10\text{V}$ (Note 3.4)	--	25.6	--	nC
Gate-Source Charge	$Q_{gs}$		--	6.8	--	
Gate-Drain Charge	$Q_{gd}$		--	9.4	--	

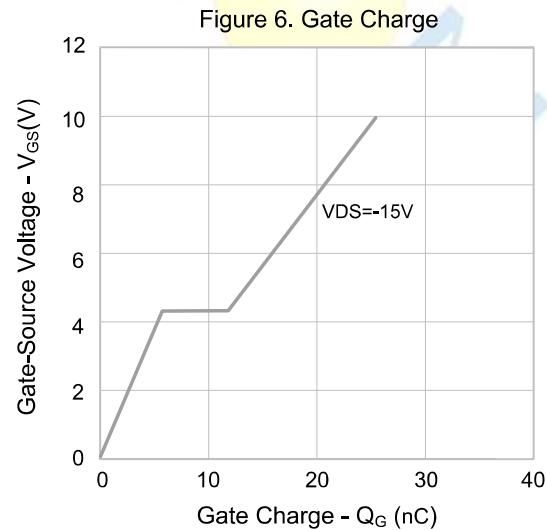
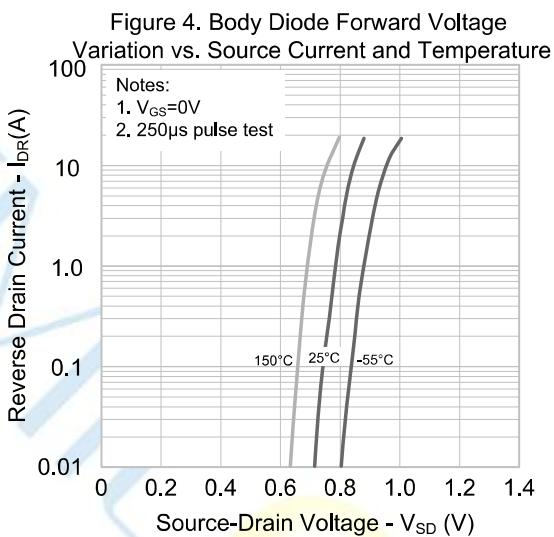
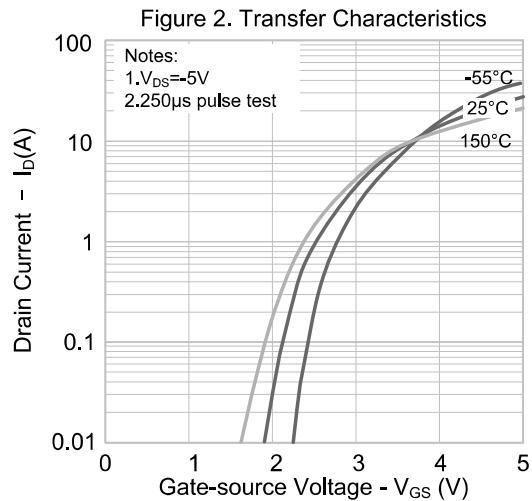
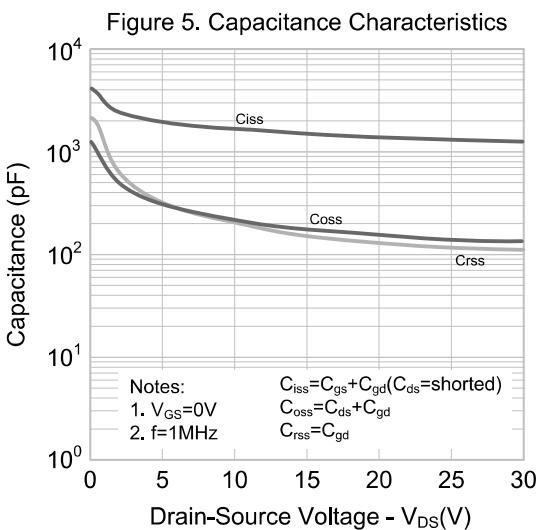
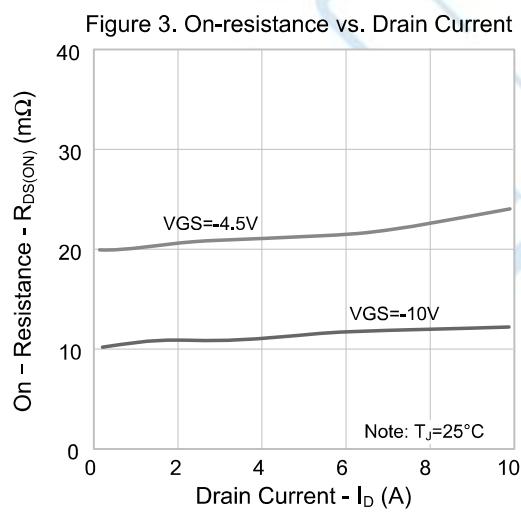
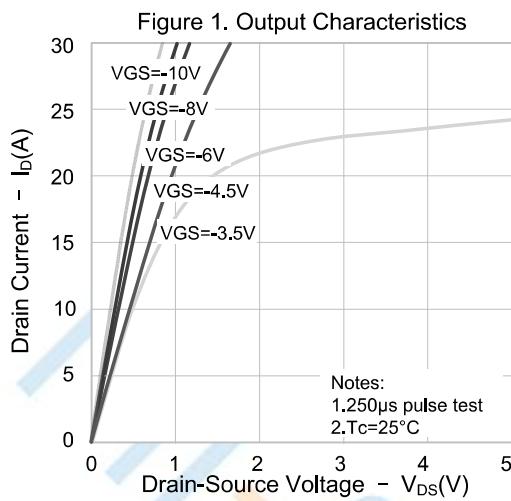
## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	-10	A
Pulsed Source Current	$I_{SM}$		--	--	-40	
Diode Forward Voltage	$V_{SD}$	$I_S = -10A, V_{GS} = 0V$	--	-0.8	-1.2	V

## NOTE:

1. Pulse width limited by maximum junction temperature
2.  $L=1mH, V_{DD}=-15V, V_G=-10V, R_G=25\Omega$ , starting  $T_J=25^\circ C$
3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$
4. Essentially independent of operating temperature

## Typical Performance Characteristics



## Typical Performance Characteristics

Figure 7. Breakdown Voltage Variation vs. Temperature

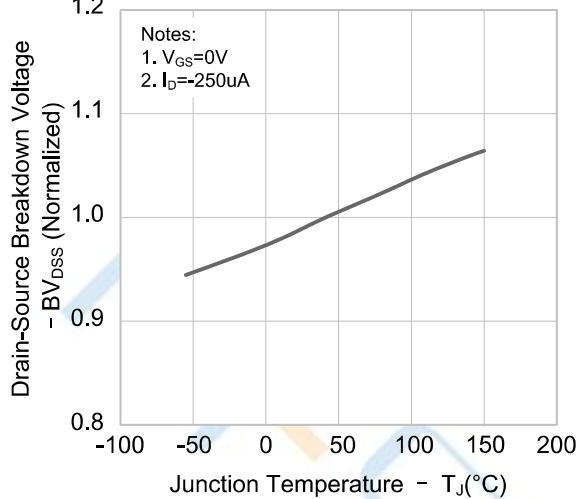


Figure 8 . On-resistance Variation vs. Temperature

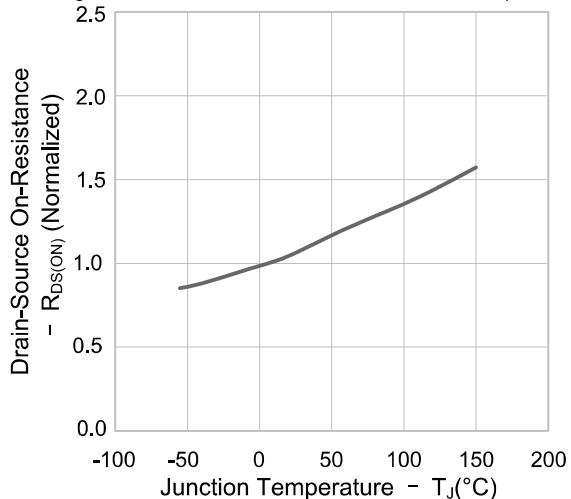
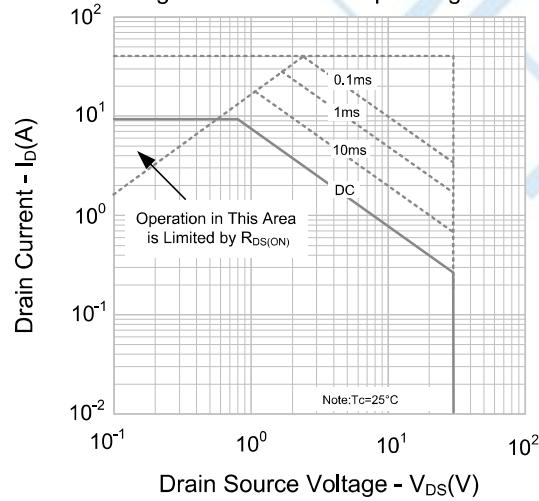
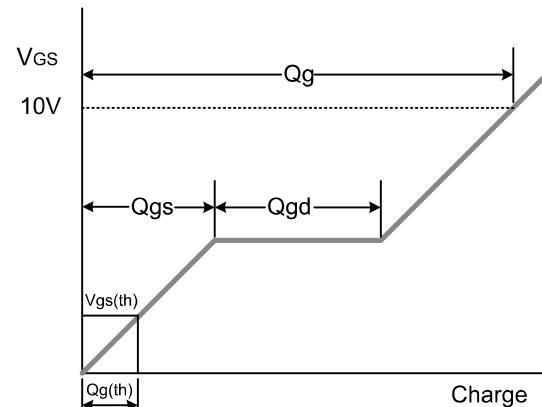
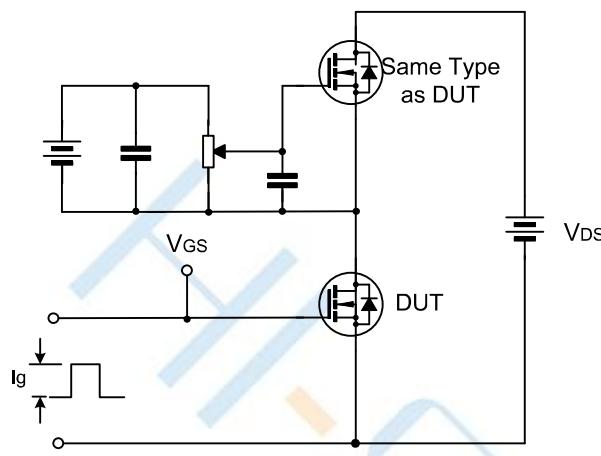


Figure 9. Max. Safe Operating Area

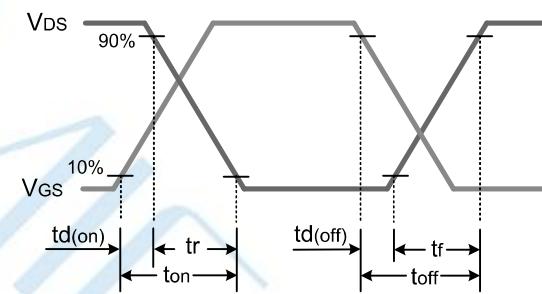
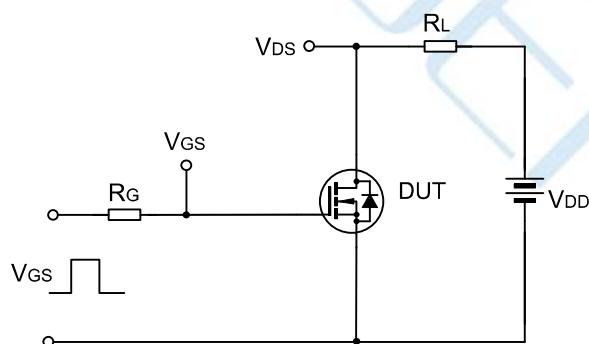


## Test Circuit

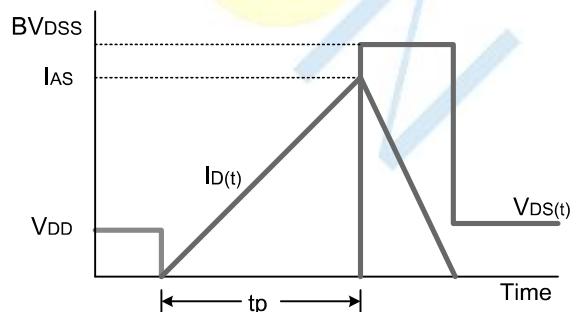
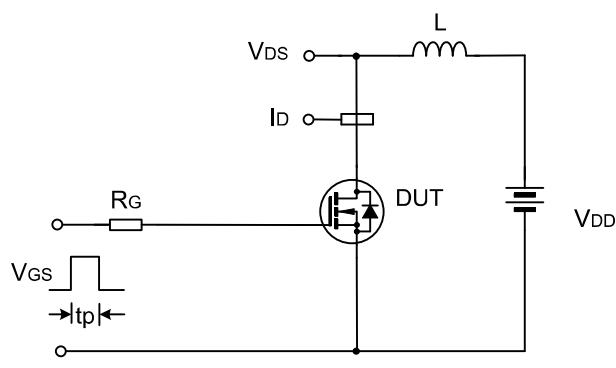
Gate Charge Test Circuit &amp; Waveform



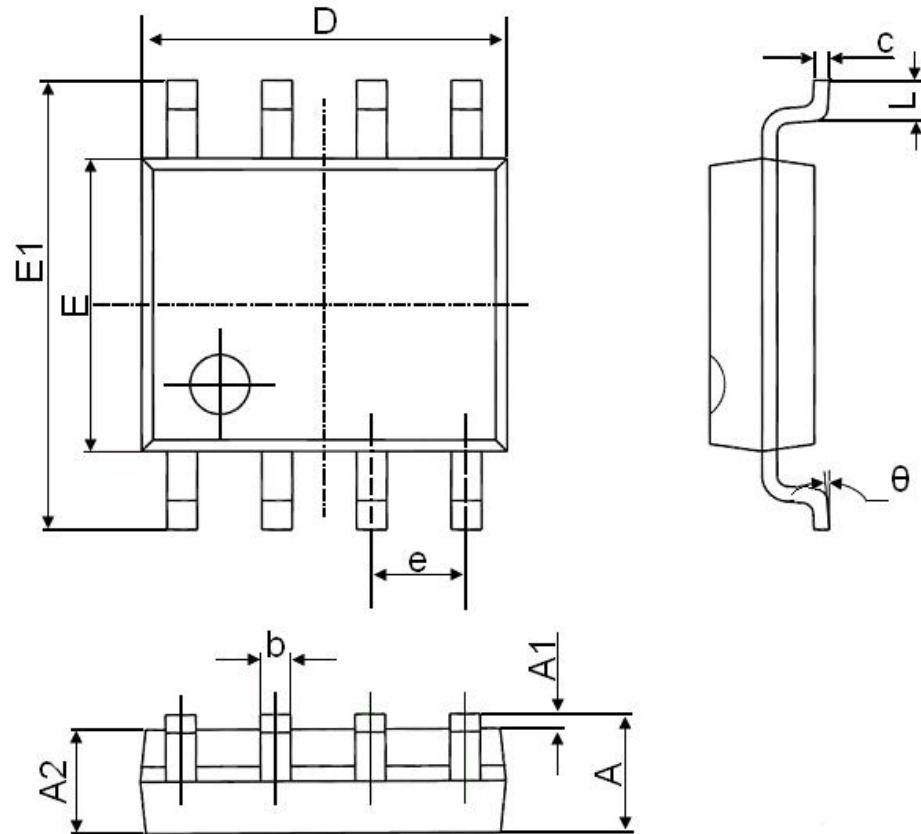
Resistive Switching Test Circuit &amp; Waveform



Unclamped Inductive Switching Test Circuit &amp; Waveform



## Package Dimensions of SOP8-8L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 (BSC)		0.050 (BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

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